IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant:

Andreev, et al.

Serial No.:

10/646,535

Filed:

August 22, 2003

Title:

SYSTEM AND METHOD FOR EFFICIENTLY TESTING A LARGE

RANDOM ACCESS MEMORY SPACE

Grp./A.U.:

2138

Confirmation No.

9860

Examiner:

Dipakkumar B. Gandhi

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

with United States Patent and trademan	rk Office on:
October 13, 2006	(Date)
Karen Vertz	
Printed or typed name of person signi-	ng the certificate)
/Karen Vertz/	
Signature of the person signing the ce	rtificate)

Sir:

AMENDMENT UNDER 37 C.F.R. § 1.111

In response to the Examiner's Action mailed February 10, 2006, please amend the above-identified application as follows: